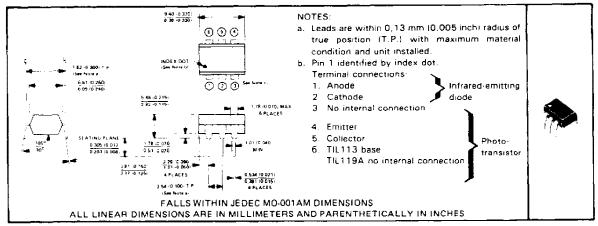
- Gallium Arsenide Diode Infrared Source Optically Coupled to a Silicon N-P-N Darlington-Connected Phototransistor
- High Direct-Current Transfer Ratio . . . 300% Minimum at 10 mA
- High-Voltage Electrical Isolation . . . 1500-Volt Rating
- Plastic Dual-In-Line Package
- Base Lead Provided on TIL113 for Conventional Transistor Biasing
- No Base Lead Connection on TIL119A for High-EMI Environments
- Typical Applications Include Remote Terminal Isolation, SCR and Triac Triggers, Mechanical Relays, and Pulse Transformers

mechanical data

The package consists of a gallium arsenide infrared-emitting diode and an n-p-n silicon darlington-connected phototransistor mounted on a 6-lead frame encapsulated within an electrically nonconductive plastic compound. The case will withstand soldering temperature with no deformation and device performance characteristics remain stable when operated in high-humidity conditions. Unit weight is approximately 0.52 grams.



absolute maximum ratings at 25°C free-air temperature (unless otherwise noted)

| Input-to-Output Voltage |
|---|
| Collector-Base Voltage (TIL113) |
| Collector-Emitter Voltage (See Note 1) |
| Emitter-Collector Voltage |
| Emitter-Base Voltage (TIL113) |
| Input Diode Reverse Voltage |
| Input Diode Continuous Forward Current at (or below) 25°C Free-Air Temperature (See Note 2) |
| Continuous Power Dissipation at (or below) 25°C Free-Air Temperature: |
| Infrared-Emitting Diode (See Note 3) |
| Phototransistor (See Note 4) |
| Total (Infrared-Emitting Diode plus Phototransistor, See Note 5) |
| Storage Temperature Range |
| Lead Temperature 1,6 mm (1/16 Inch) from Case for 10 Seconds |

1. This value applies when the base emitter diode is open circuited

- Derate linearly to 100°C free air temperature at the rate of 1.33 mA. C
- 3. Denote linearly to 100 C free air temperature at the rate of 2 mW/ $C_{\rm c}$
- Denste linearly to 100°C free air temperature at the rate of 2 mW/ C 5. Denate linearly to 100°C free-air temperature at the rate of 3.33 mW/ C

PRODUCTION DATA documents contain information current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing documents assessmenty include testing of all parameters.



TIL113, TIL119A OPTOCOUPLERS

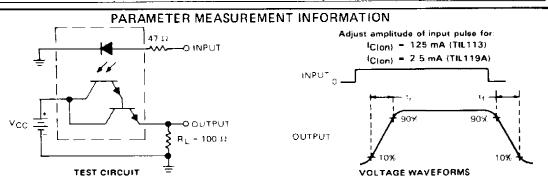
electrical characteristics at 25°C free-air temperature

| PARAMETER | | TEST CONDITIONS [†] | | | TIL113 | | | TIL119A | | | UNIT |
|---------------------|--|-------------------------------|-------------------------|------------------------|--------|--------|-----|---------|-----|-----|------|
| | | | | | MIN | | MAX | MIN | TYP | MAX | UNIT |
| V(BR)CBO | Collector Base Breakdown Voltage | I _C = 10 μA, | ι _Ε - 0, | 1 _F - 0 | 30 | | | | | | V |
| V(BR)CEO | Collector-Emitter Breakdown Voltage | IC ÷ 1 mA. | +B = 0. | IF - 0 | 30 | | | 30 | | | V |
| V(BR)EBO | Emitter-Base Breakdown Voltage | IE = 10 μA, | IC . 0' | F - 0 | 7 | | | | | | V |
| V(BR)ECO | Emitter-Collector Breakdown Voltage | le = 10 μA. | lt = 0 | | | | | 7 | | | ٧ |
| 1 | On State | VCE = 1 V. | ig 0, | 1 _F = 10 mA | 30 | 100 | | | | | mA |
| ¹ C(on) | Collector Current | V _{CE} = 1 V. | I _F = 10 mA | | | | | 30 | 160 | _ | |
| I _{C(off)} | Off-State Collector Current | V _{CE} = 10 V. | IB - 0, | 1 _F - 0 | i | | 100 | | | 100 | пA |
| ηFE | Transistor Static Forward Current Transfer Ratio | V _{CE} - 1 V, | I _C - 10 mA. | le = 0 | | 15,000 | | | | | |
| v _F | Input Diode Static Forward Voltage | 1p = 10 mA | | | | | 1.5 | | | 1.5 | V |
| | Collector-Emitter | Ic = 125 mA. | l _B = 0, | l _F : 50 mA | • | | 1.2 | | | | |
| VCE (sat) | Saturation Voltage | IC = 30 mA, | lp = 10 mA | | | | | | | 1 |] |
| 110 | Input-to-Output Internal Resistance | V _{in-out} = +1.5 kV | , See Note 6 | | 1011 | | | 1011 | | | 13 |
| Cio | Input-to-Output Capacitance | V _{in out} 10, | f= 1 MHz. | See Note 6 | | 1 | 13 | | 1 | 1.3 | pΕ |

NOTE 6: These parameters are measured between both input-diode leads shorted together and all the phototransistor leads shorted together. *Reference to the base are not applicable to TiL119A.

switching characteristics at 25 C free-air temperature

| | DADAMETER | TEST CONDITIONS | | TL113 | | | TIL119A | | | UNIT |
|----|-----------|-------------------------|------------------------------|-------|-----|-----|---------|-----|-----|------|
| r | PARAMETER | 15 | 21 CONDITIONS | MIN | TYP | MAX | MIN | TYP | MAX | UNIT |
| ī, | Rise Time | V _{CC} - 15 V. | Iclon) = 125 mA, | | 300 | | | | | |
| f | Fall Time | R _L = 100 Ω, | See Figure 1 | | 300 | | | | | μS |
| r | Rise Time | V _{CC} = 10 V. | I _{C(on)} = 2.5 mA, | | | | 300 | | | |
| f | Fall Time | | See Figure 1 | | | | | 300 | | 448 |

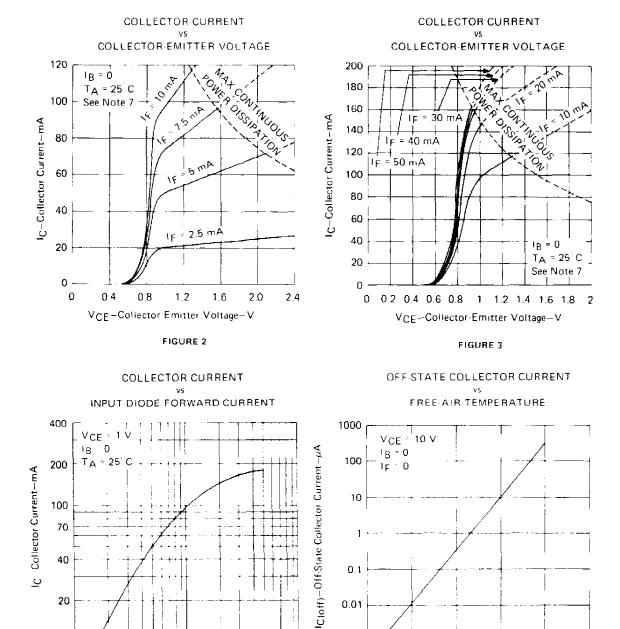


- NOTES: a The input waveform is supplied by a generator with the following characteristics: $Z_{out} = 50 \Omega_c t_f \approx 15 \text{ ns. duty cycle} \approx 1\%$.
 - $t_W=500~\mu s$.

 b. The output waveform is monitored on an oscilloscope with the following characteristics: $t_r \lesssim 12~ns,~R_{in} \approx 1~M\Omega,~C_{in} \lesssim 20~pF$

FIGURE 1-SWITCHING TIMES

TYPICAL CHARACTERISTICS



NOTE 7. Pulse operation of input diode is required for operation beyond limits shown by dotted line.

20

10 Ip-Forward Current-mA

FIGURE 4

40

70 100

20

10

2



0.01

0.001

0

75

100

125

50

TA-Free-Air Temperature- C

FIGURE 5

0

-75 -50 -25

TYPICAL CHARACTERISTICS

TRANSISTOR STATIC FORWARD RELATIVE COLLECTOR-EMITTER SATURATION VOLTAGE **CURRENT TRANSFER RATIO** ٧S FREE AIR TEMPERATURE **COLLECTOR CURRENT** 1.6 25,000 VCE(sat)—Collector-Emitter Saturation Voltage IC = 125 mA VCE = 1 V hpe-Static Forward Current Transfer Ratio 18 = 0 |F = 0 1.4 IF = 50 mA $T_A = 25^{\circ}C$ Relative to Value at TA = 25°C 20,000 1.2 1.0 15,000 0.8 10,000 0.6 0.4 5,000 0.2

75 100 125

0

0.1

0.4

FIGURE 6

25 50

TA-Free-Air Temperature-°C

0

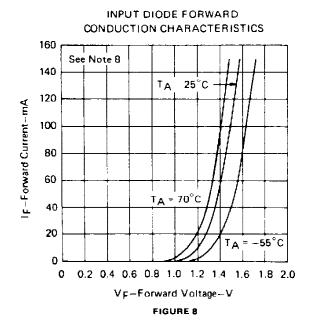
FIGURE 7

10

IC-Collector Current-mA

40 100

400 1000



NOTE 8: This parameter was massured using pulse techniques, t_w = 1 ms, duty cycle ≤ 2%.

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